

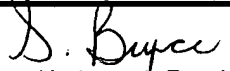


Issue Classification

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/017,500	SIRHAN ET AL.	
Examiner	Art Unit	
Hieu Phan	3738	

ISSUE CLASSIFICATION												
ORIGINAL					CROSS REFERENCE(S)							
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
424		423			424	435						
INTERNATIONAL CLASSIFICATION												
A	6	1	F	2/00								
A	6	1	F	13/00								
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				/								
				/								

 (Assistant Examiner)	10/02/05 (Date)	 David H. Willse Primary Examiner (Primary Examiner)	10-3-05 (Date)	Total Claims Allowed: 31
 (Legal Instruments Examiner)	10/3/05 (Date)			O.G. Print Claim(s) 1
				O.G. Print Fig. 1 C

[illegible]